



Form PTO-1449 Modified  List of Patent and Publications Cited by Applicant (Use several sheets if necessary) U.S. Department of Commerce Patent and Trademark Office	Docket No. N1280-00100(TSMC2003-841)	Serial No. Unassigned
	Applicant Chung-Hui Chen et al.	
	Filing Date 02/23/2004	Group Unknown

### U. S. PATENT DOCUMENTS

Examiner Initial	Cite No.	Document No.	Kind Code (if known)	Name	Date	Class	Subclass
CD	1.	6,507,087 B1		Yu	01/14/2003	257/529	
CD	2.	6,445,606 B1		Khoury	09/03/2002	365/96	
CD	3.	6,436,738 B1		Yu	08/20/2002	438/132	
CD	4.	6,208,549 B1		Rao et al.	03/27/2001	365/96	

### FOREIGN PATENT DOCUMENTS

Examiner Initial	Cite No.	Country Code	Number	Kind Code	Publication Date	Name of Patentee or Applicant	Page, Columns, Lines where Relevant Passages Appeal	T

### OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Initial	Cite No.	(Include name of author in CAPITAL LETTERS, Title of the Article (when appropriate) title of the item (book, magazine, journal, symposium, catalog, etc.) date, pages, volume, issue number(s), publisher, city and/or country where published)	T
CD	5.	Ker, Ming-Dou et al., "CAPACITOR-COUPLE ESD PROTECTION CIRCUIT FOR DEEP-SUBMICRON LOW-VOLTAGE CMOS ASIC", IEEE Transactions on Very Large Scale Integration (VLSI) Systems, Vol. 4, No. 3, (SEPT. 1996), pp. 307-321	
CD	6.	Ker, Ming-Dou et al., "COMPLEMENTARY-SCR ESD PROTECTION CIRCUIT WITH INTERDIGITATED FINGER-TYPE LAYOUT FOR INPUT PADS OF SUBMICRON CMOS IC'S", IEEE Transactions on Electron Devices, Vol. 42, No. 7, (JUL 1995), pp. 1297-1304	
CD	7.	Wu et al., A NEW ON-CHIP ESD PROTECTION CIRCUIT WITH DUAL PARASITIC SCR STRUCTURES FOR CMOS VLSI, IEEE Journal of Solid-State Circuits, Vol. 27, No. 3, (MAR 1992), pp. 274-280	

EXAMINER SON DINH	DATE CONSIDERED 6/11/05
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